



NFC TEST REPORT

No.I21Z60291-IOT03

for

TCL Communication Ltd.

GSM/UMTS/LTE mobile phone

T774B,T775B

FCC ID : 2ACCJN054

with

Hardware Version: 03

Software Version: v3.0.9DF2

Issued Date: 2021-03-05

Note:

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The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S.Government.

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REPORT HISTORY

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1. Test Laboratory

1.1. Introduction & Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2017 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (ISED#: 24849). The detail accreditation scope can be found on NVLAP website.

1.2. Testing Location

Location 1: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,
P. R. China 100191

Location 2: CTTL(CuiHu)

Address: CuiHu Cloud Center No.1 Gaolizhang Road,Wenquan
Town,Haidian District,Beijing,China

1.3. Testing Environment

Normal Temperature: 15-35°C
Extreme Temperature: -20/+50°C
Normal Relative Humidity: 20-75%
Normal Air Pressure: 86Kpa-106Kpa

1.4. Project data

Testing Start Date: 2021-02-23
Testing End Date: 2021-02-23

1.5. Signature



Zhou Bin
(Prepared this test report)



Zhang Qiang
(Reviewed this test report)



Zhu Liang
(Approved this test report)

2. Client Information

2.1. Applicant Information

Company Name: TCL Communication Ltd.
Address: 5/F,Building 22E,22 Science Park East Avenue,Hong Kong Science Park,Shatin,NT,Hong Kong
Country: China
Contact: Gong Zhizhou
Telephone: 0086-755-36611722
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2.2. Manufacturer Information

Company Name: TCL Communication Ltd.
Address: 5/F,Building 22E,22 Science Park East Avenue,Hong Kong Science Park,Shatin,NT,Hong Kong
Country: China
Contact: Gong Zhizhou
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3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description	GSM/UMTS/LTE mobile phone
Model name/HVIN	T774B,T775B
FCC ID	2ACCJN054
UMTS Frequency Band(s)	FDD I/II/IV/V/VIII
GSM Frequency Band(s)	GSM 850/900/1800/1900
E-UTRA Frequency Band(s)	FDD1/2/3/4/5/7/8/12/13/17/20/25/26/28/28a/28b/29CA/66/71 TDD 38/40/41
Operating Temperature	0/+40°C
Nominal Voltage	3.85V
Extreme High Voltage	4.4V
Extreme Low Voltage	3.6V

3.2. Internal Identification of EUT

EUT ID*	IMEI/SNI	HW Version	SW Version	Date of receipt
11a	351897970000141	03	v3.0.9DF2	2021-02-22
12a	351897970000133	03	v3.0.9DF2	2021-02-22

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE

AE ID*	Description	SN
AE1	Battery	/
AE2	Battery	/
AE3	USB Cable	/
AE4	USB Cable	/
AE5	Charger	/
AE6	NFC Card	/

AE1

Model	TLp048A1
Manufacturer	BYD
Capacity	4360 mAh

Nominal Voltage	3.85V
AE2	
Model	TLp048A7
Manufacturer	VEKEN
Capacity	4360 mAh
Nominal Voltage	3.85V
AE3	
Model	CDA0000128C1
Manufacturer	Juwei
Length of cable	/
AE4	
Model	CDA0000128C2
Manufacturer	Shenghua
Length of cable	/
AE5	
Model	UC13US
Manufacturer	PUAN
Length of cable	/

*AE ID: is used to identify the ancillary equipment in the lab internally.

3.4. EUT Set-ups

Table 1: Eut Set-ups

EUT Set-up No.	Combination of EUT and AE	Remarks
Set.NFC01	12a + AE1/AE2 + AE3/AE4 + AE5 + AE6	--
Set.NFC02	12a + AE1/AE2 + AE6	--
Set. NFC03	11a	--

The Transmit State of NFC: the NFC function is on. The EUT will transmit the NFC data and command continuously during the test.

The Transmit state without modulation: The EUT will transmit the CW signal at the operating frequency.

4. Reference Documents

4.1. Documents supplied by applicant

EUT parameters, referring to Annex A for detailed information, are supplied by the client or manufacturer, which are the bases of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
CFR 47 Part 2	Part 2 — Frequency Allocations and Radio Treaty Matters; General Rules and Regulations.	2018
CFR 47 Part 15	Part 15 — Radio Frequency Devices. Subpart C — Intentional Radiators. § 15.35 Measurement detector functions and bandwidths. § 15.207 Conducted limits. § 15.209 Radiated emission limits, general requirements. § 15.215 Additional provisions to the general radiated emission limitations. § 15.225 Operation within the band 13.110–14.010 MHz.	2018
ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	2013

5. Test Results

5.1. Summary of Test Results

Table 2: Summary of Test Results

No	Test Cases	Clause in Regulation	Section in This Report	Verdict
1	Electric Field Strength of Fundamental Emissions	CFR 47 § 15.225(a)	B.1	P(Set. NFC02)
2	Electric Field Strength of Outside the Allocated Bands	CFR 47 § 15.225(b) CFR 47 § 15.225(c)		P(Set. NFC02)
3	Electric Field Radiated Emissions	CFR 47 § 15.209	B.2	P(Set. NFC01)
		CFR 47 § 15.225(d)	B.3	P(Set. NFC01)
4	Frequency Tolerance	CFR 47 § 15.225(e)	B.4	P(Set. NFC03)
5	20dB Bandwidth	CFR 47 § 15.215(c)	B.5	P(Set. NFC03)
6	Conducted Emissions	CFR 47 § 15.207	B.6	P(Set. NFC01)
The measurement is carried out according to ANSI C63.10. See ANNEX B for details.				

Test Conditions:

For this report, all the test cases listed above were tested under normal Temperature, Voltage, humidity and Air Pressure except the Frequency Tolerance test case. The specific conditions of Frequency Tolerance test case are listed in section B.4.3

See **Table 3** for terms for result verdict:

Table 3 Terms for result verdict

P	Pass, The EUT complies with the essential requirements in the standard.
NP	Not Perform, The test was not performed by CTTL
NA	Not Applicable, The test was not applicable
F	Fail, The EUT does not comply with the essential requirements in the standard

5.2. Statements

The test cases listed in Section 5.1 of this report for the EUT specified in Section 3 were performed by CTTL according to the reference documents in Section 4.

The EUT meets all applicable requirements of the regulations and standards in Section 4.2.

6. Test Facilities Utilized

Table 4: Test Facilities Utilized

NO.	NAME	TYPE	SERIES NUMBER	PRODUCER	CAL. DUE DATE	CAL. INTERVAL
1.	Spectrum Analyzer	RSA3408A	B010277	Tektronix	2021-10-23	1 Year
2.	Climatic chamber	SH242	93008658	ESPEC	2022-01-22	1 Year
3.	Test Receiver	ESU26	100235	Rohde & Schwarz	2022-02-23	1 Year
4.	BiLog Antenna	VULB9163	9163-1223	Schwarzbeck	2021-03-18	1 Year
5.	LISN	ENV216	101200	R&S	2021-05-19	1 Year
6.	Test Receiver	ESCI	100344	R&S	2022-02-23	1 Year
7.	H-field Antenna	HFH2-Z2	829324	R&S	2021-12-10	1 Year

7. Measurement Uncertainty

Table 5: Measurement Uncertainty

Item	Uncertainty
Frequency Tolerance	$U = 77 \text{ Hz, } k=2$
20dB Bandwidth	$U = 77 \text{ Hz, } k=2$
Radiated Emissions (<1GHz)	$U = 4.86 \text{ dB, } k=2$
Radiated Emissions (>1GHz)	$U = 5.16 \text{ dB, } k=2$
Conducted emission	$U = 3.10 \text{ dB, } k=2$

ANNEX A: EUT parameters

/

ANNEX B: Detailed Test Results

B.1. Electric Field Strength of Fundamental and Outside the Allocated bands

B.1.1. Reference

See Clause 4, Clause 5 of ANSI C63.10-2013 generally.

B.1.2. Measurement Methods

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Table B-1: Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
12.56-14.56	10/30 kHz

The E-field measured at 3m is calculated as:

$$\text{E-field (dB}\mu\text{V/m)} = \text{Rx (dB}\mu\text{V)} + \text{Cable Loss (dB)} + \text{AF@3m (dB/m)}$$

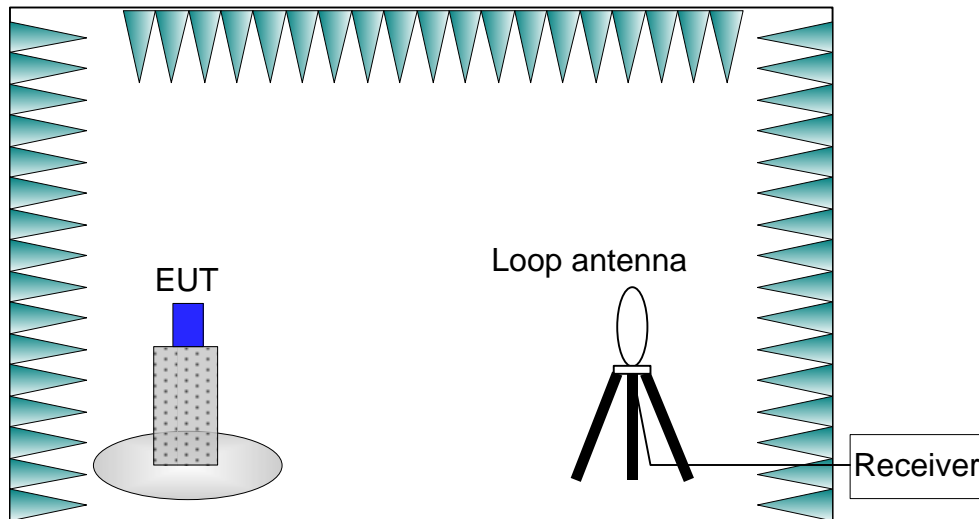


Figure B-1: Measurement Setup

B.1.3. EUT Operating Mode and Test Conditions

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15 ~ 25 °C.

B.1.4. Limits

Table B-2: Limits

Frequency Range (MHz)	E-field Strength Limit @ 30 m ($\mu\text{V/m}$)	E-field Strength Limit @ 3 m ($\text{dB}\mu\text{V/m}$)
13.560 ± 0.007	+15,848	124
13.410 to 13.553 13.567 to 13.710	+334	90
13.110 to 13.410 13.710 to 14.010	+106	81
Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula: $\text{Extrapolation(dB)} = 40\log_{10}(\text{Measurement Distance}/\text{Specification Distance})$		

B.1.5. Measurement Results

Measurement results of normal conditions see Figure B-2 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC02, **PASS**.

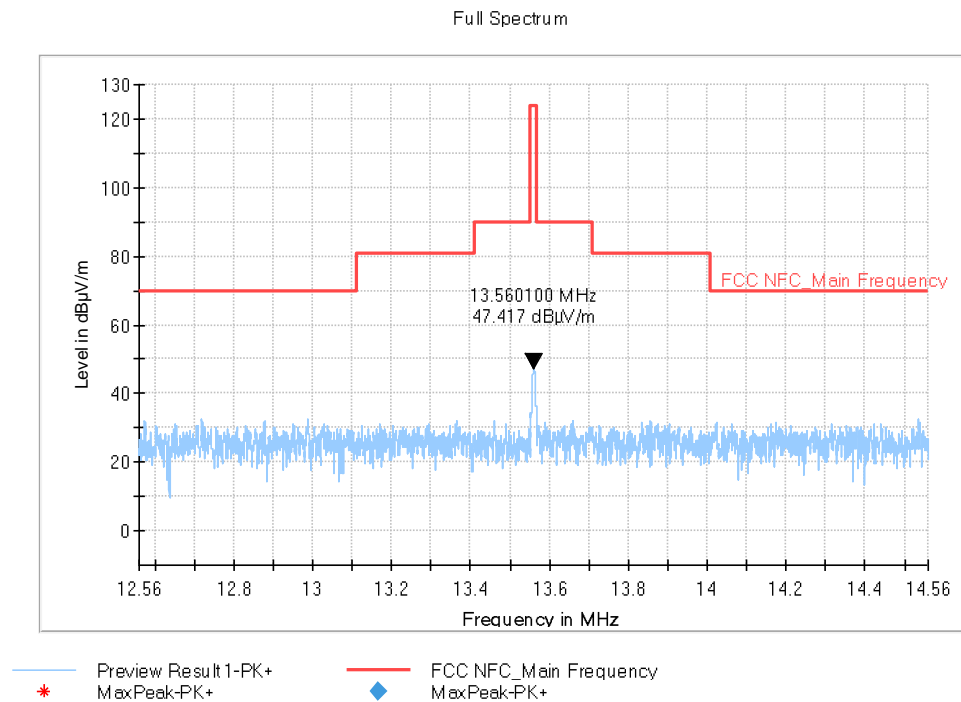


Figure B-2: Measurement results for Electric Field Strength of Fundamental and Outside the Allocated bands

B.2. Electric Field Radiated Emissions (< 30MHz)

B.2.1. Reference

See Clause 6.4 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

B.2.2. Measurement Methods

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the

EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Table B-3: Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
0.009-0.15	100/300 Hz
0.15-30	10/30 kHz

The E-field measured at 3m is calculated as:

$$\text{E-field (dB}\mu\text{V/m)} = \text{Rx (dB}\mu\text{V)} + \text{Cable Loss (dB)} + \text{AF@3m (dB/m)}$$

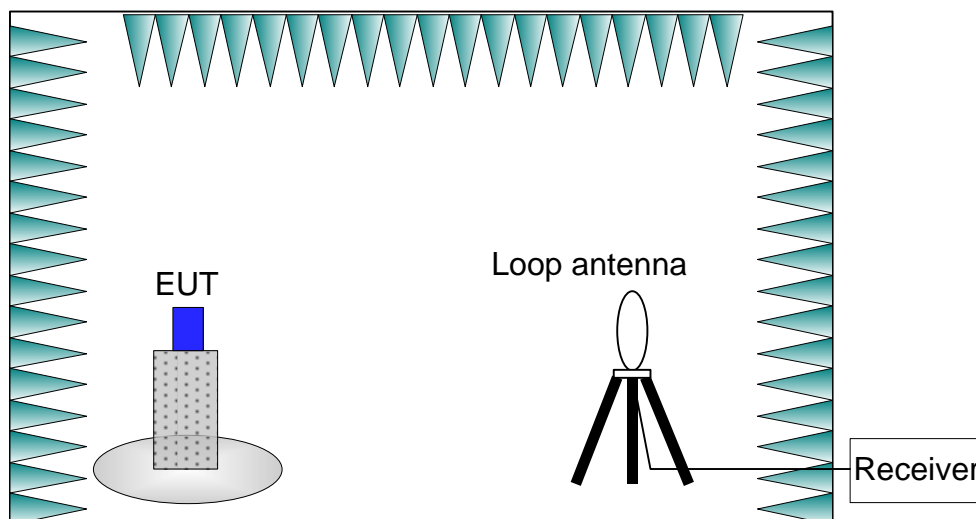


Figure B-3: Measurement Setup

B.2.3. EUT Operating Mode and Test Conditions

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15 ~ 25 °C.

B.2.4. Limits

Table B-4: Limits

Frequency Range (MHz)	E-field Strength Limit @ 30m (mV/m)	E-field Strength Limit @ 3m (dBµV/m)
0.009-0.490	2400/F(kHz)	129-94
0.490-1.705	24000/F(kHz)	74-63
1.705-30	30	70

Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula:
 Extrapolation(dB) = $40\log_{10}(\text{Measurement Distance}/\text{Specification Distance})$

B.2.5. Measurement Results

Measurement results of normal conditions see Figure B-4 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.

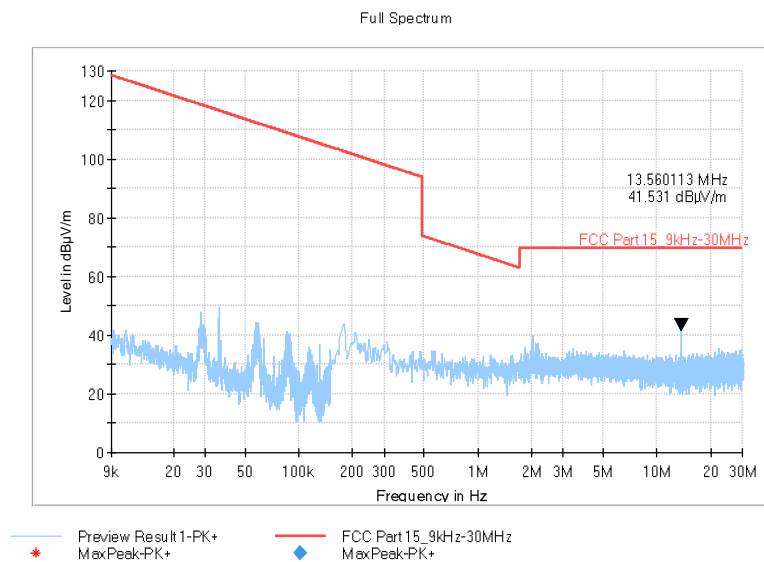


Figure B-4: Measurement results for Electric Field Radiated Emissions (< 30MHz)

B.3. Electric Field Radiated Emissions (≥30MHz)

B.3.1. Reference

See Clause 6.5 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

B.3.2. Measurement Methods

The electric field radiated emissions from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 10m from the receiving antenna. The receiving antennas connected to a measurement receiver. In order to search for maximum field strength emitted from the EUT, the receiving antenna can be moved between the height of 1.0 m to 4.0 m. Detected E-field was maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna positions for both vertical and horizontal antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Table B-5: Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
30-1000	120kHz

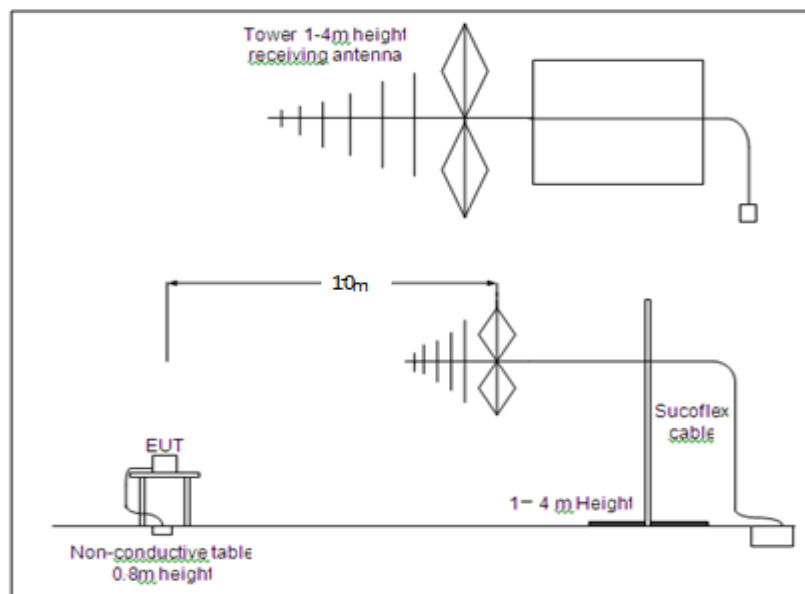


Figure B-5: Measurement Setup

B.3.3. EUT Operating Mode and Test Conditions

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT had been connected to a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15 ~ 25 °C.

B.3.4. Limits

Table B-6: Limits

Frequency Range (MHz)	E-field Strength Limit @ 3m (mV/m)	E-field Strength Limit @ 3m (dBµV/m)	E-field Strength Limit @ 10m (dBµV/m)
30-88	100	40	30
88-216	150	43.5	33.5
216-960	200	46	36
960-1000	500	54	44

B.3.5. Measurement Results

Measurement results of normal conditions see Figure B-6 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.

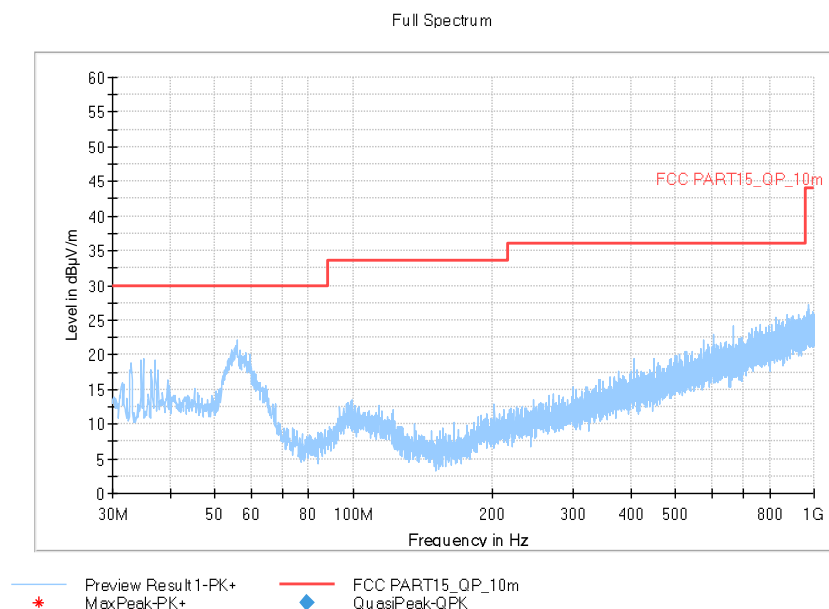


Figure B-6: Measurement results for Electric Field Radiated Emissions (≥30MHz)

B.4. Frequency Tolerance

B.4.1. Reference

See Clause 6.8 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

B.4.2. Measurement Methods

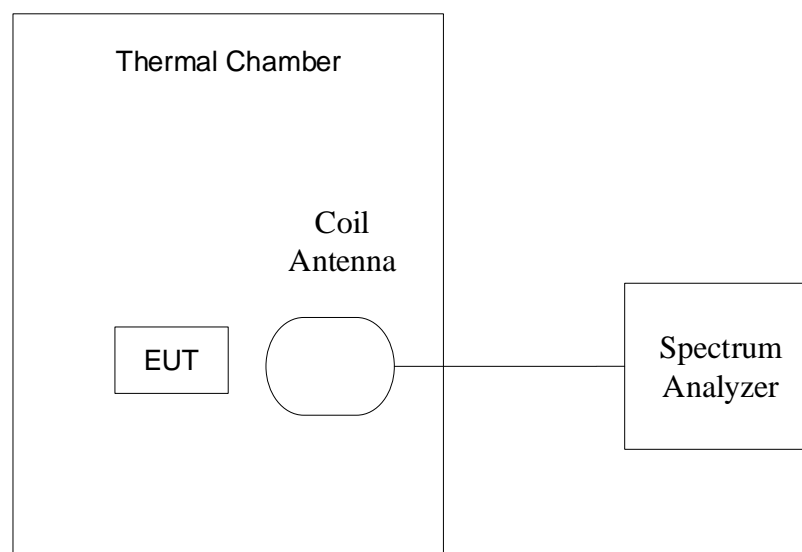


Figure B-7: Measurement Setup

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The center frequency was measured with 30Hz RBW and 1kHz span.

During the test, the EUT was placed in a thermal chamber until thermal balance and lasting appropriate time.

B.4.3. EUT Operating Mode and Test Conditions

The measurement of EUT was carried out under the transmit state of without modulation(See 3.4).

EUT had not been connected to a travel adapter. The frequency stability was measured with the different voltage and temperature combinations:

- a) The nominal voltage 3.85V(See 3.1)was used and the temperature was varied from -20°C to +50°C in 10°C increments using an environmental chamber.

- b) The 20°C was used and the voltages were 3.6V, 3.85V and 4.4V (The extreme low voltage ,the nominal voltage and the extreme high voltage defined in section 3.1).

The details were as following:

Table B-7: Combinations of Voltage and Temperature

Test items	Voltage	Temperature
Frequency stability with respect to ambient temperature	3.85V	-20°C
		-10°C
		0°C
		10°C
		20°C
		30°C
		40°C
		50°C
Frequency stability when varying supply voltage	3.6V	20°C
	3.85V	
	4.4V	

B.4.4. Test Layouts

See B.4.2.

B.4.5. Limits

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency.

B.4.6. Measurement Results

Measurement results see Table B-8 for different test conditions.

Conclusions: Set.NFC03, **PASS**.

Table B-8: Measurement results for Frequency Tolerance

Temperature	Voltage	Frequency (MHz)			
		Startup	2 Min Later	5 Min Later	10 Min Later
-20°C	3.85V	13.560026875	13.560021875	13.560021125	13.560020725
-10°C	3.85V	13.560041875	13.560045625	13.560048125	13.560049375
0°C	3.85V	13.560051875	13.560052325	13.560053123	13.560054375
10°C	3.85V	13.560041875	13.560040625	13.560039375	13.560037525
20°C	3.85V	13.560016875	13.560014375	13.560013125	13.560011875
30°C	3.85V	13.559988125	13.559985625	13.559981875	13.559979375
40°C	3.85V	13.559973125	13.559959375	13.559954375	13.559952125
50°C	3.85V	13.559938125	13.559936875	13.559936250	13.559936125
20°C	3.6V	13.560000625	13.560005625	13.560008125	13.560009375
20°C	4.4 V	13.559993125	13.559998125	13.560003125	13.560005652

Temperature	Voltage	Frequency Error (%)			
		Startup	2 Min Later	5 Min Later	10 Min Later
-20°C	3.85V	0.000	0.000	0.000	0.000
-10°C	3.85V	0.000	0.000	0.000	0.000
0°C	3.85V	0.000	0.000	0.000	0.000
10°C	3.85V	0.000	0.000	0.000	0.000
20°C	3.85V	0.000	0.000	0.000	0.000
30°C	3.85V	0.000	0.000	0.000	0.000
40°C	3.85V	0.000	0.000	0.000	0.000
50°C	3.85V	0.000	0.000	0.000	0.000
20°C	3.6V	0.000	0.000	0.000	0.000
20°C	4.4V	0.000	0.000	0.000	0.000

B.4.7. Measurement Uncertainty

Measurement uncertainty: $U = 77 \text{ Hz}$, $k=2$

B.5. 20dB Bandwidth

B.5.1. Reference

See Clause 6.9 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

B.5.2. Measurement Methods

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The bandwidth of the center frequency was measured with 140Hz RBW, 420Hz VBW and 14kHz span.

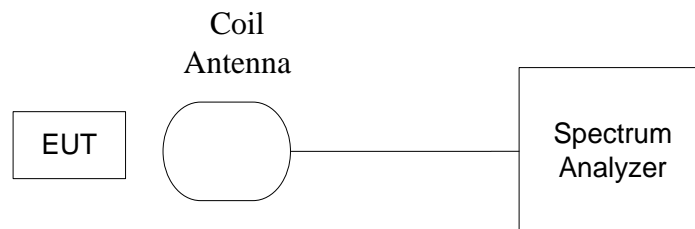


Figure B-8: Measurement Setup

B.5.3. EUT Operating Mode and Test Conditions

The measurement of EUT was carried out under the transmit state of NFC (See 3.4).

EUT had not been connected to a travel adapter.

During the measurements, the ambient temperature was in the range of 15 ~ 25 °C.

B.5.4. Test Layouts

See B.5.2.

B.5.5. Limits

The 20dB bandwidth shall be less than 80% of the permitted frequency band. For 13.56 MHz NFC, the permitted frequency band is 14kHz, so the limit is 11.2 kHz.

B.5.6. Measurement Results

Measurement results see Figure B-9.

Conclusions: Set.NFC03, **PASS**.

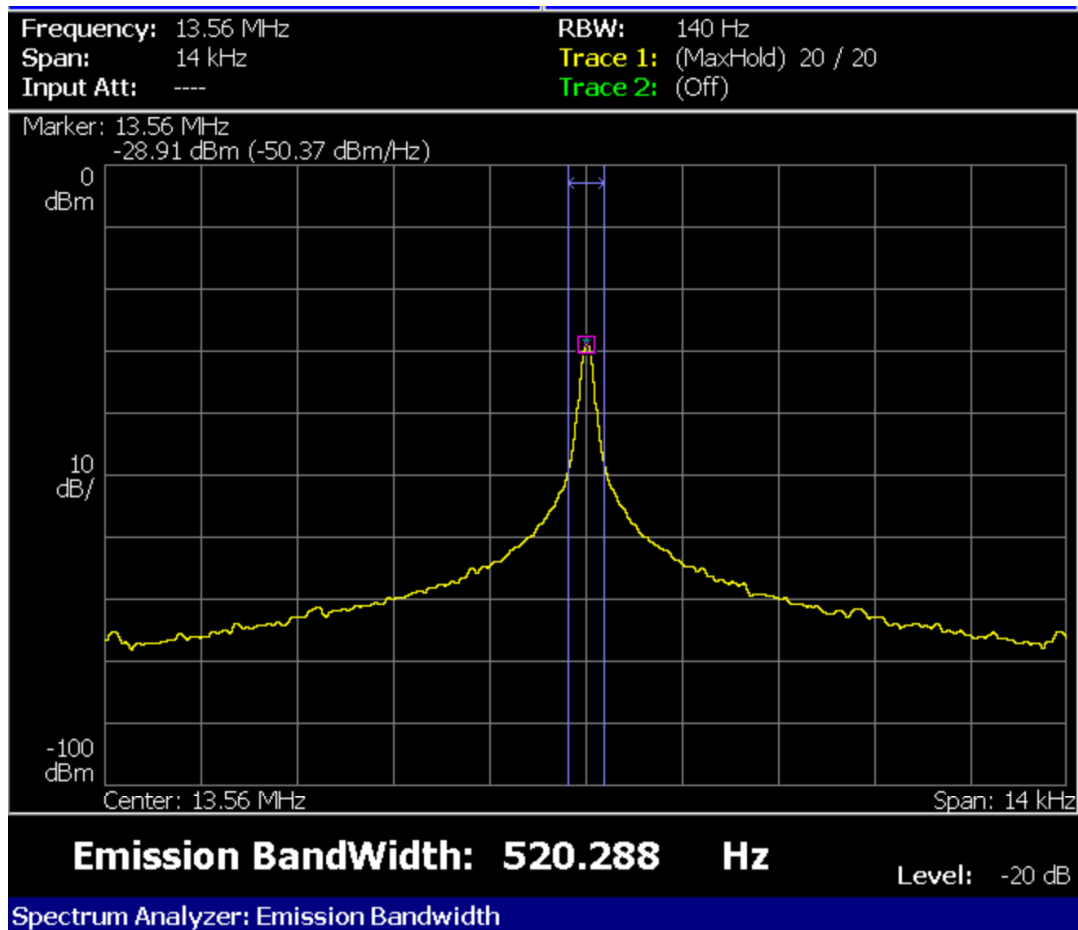


Figure B-9: Measurement results for 20dB Bandwidth

B.5.7. Measurement Uncertainty

Measurement uncertainty: $U = 77 \text{ Hz}$, $k=2$

B.6. Conducted emission

B.6.1. Reference

See Clause 6.2 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

B.6.2. Measurement Methods

The conducted emissions from the AC port of the EUT are measured in a shielding room. The EUT

is connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection was performed. The measurements were performed with a quasi-peak detector and if required, an average detector.

The conducted emission measurements were made with the following detector of the test receiver: Quasi-Peak / Average Detector.

The measurement bandwidth is:

Table B-9: Measurement Bandwidth

Frequency of Emission (MHz)	RBW/VBW
0.15-30	9kHz

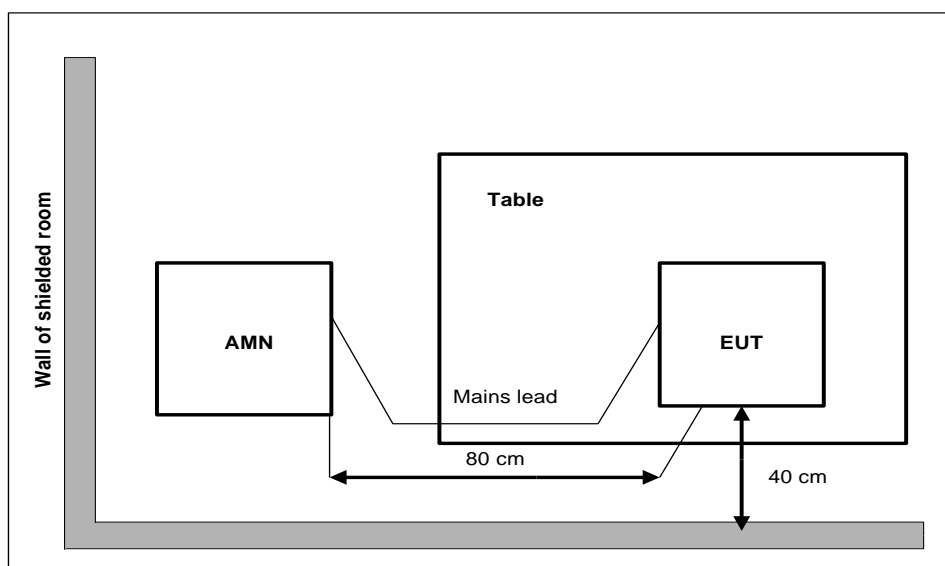


Figure B-10: Measurement Setup

B.6.3. EUT Operating Mode and Test Conditions

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

All possible configurations were investigated and only the worst case is reported.

During the measurements, the ambient temperature is in the range of 15 ~ 25 °C.

B.6.4. Limits

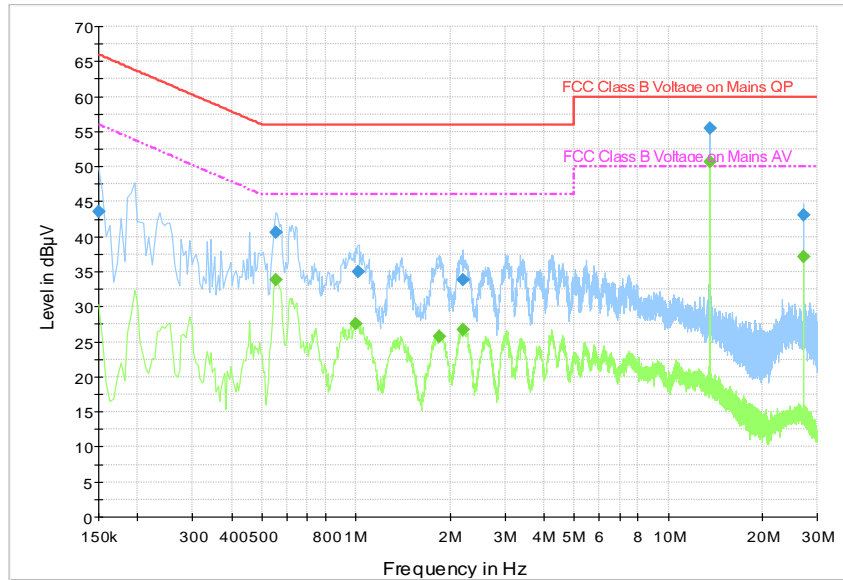
Table B-10: Limits

Frequency range (MHz)	Quasi-peak Limit (dB μ V)	Average Limit (dB μ V)
0.15 to 0.5	66 to 56	56 to 46
0.5 to 5	56	46
5 to 30	60	50

B.6.5. Measurement Results

Measurement results see Figure B-11.

Conclusions: Set.NFC01, **PASS.**



Note: the spike over the limit is the NFC carrier frequency and coming from the radio equipment.

Figure B-11: Measurement results for Conducted Emission

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.150000	43.6	1000.0	9.000	On	L1	19.6	22.4
0.555000	40.6	1000.0	9.000	On	L1	19.6	15.4
1.018500	35.0	1000.0	9.000	On	L1	19.6	21.0
2.193000	33.8	1000.0	9.000	On	L1	19.6	22.2
13.560000	55.5	1000.0	9.000	On	L1	19.9	4.5
27.118500	43.0	1000.0	9.000	On	N	20.0	17.0

Final Result 2



Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.555000	33.9	1000.0	9.000	On	L1	19.6	12.1
1.000500	27.6	1000.0	9.000	On	L1	19.6	18.4
1.846500	25.8	1000.0	9.000	On	L1	19.5	20.2
2.193000	26.7	1000.0	9.000	On	L1	19.6	19.3
13.560000	50.6	1000.0	9.000	On	L1	19.9	-0.6
27.123000	37.1	1000.0	9.000	On	L1	20.2	12.9

ANNEX C: Persons involved in this testing**Table C-1: Persons involved**

Test Item	Tester
20dB Bandwidth	Zhou Bin
Frequency Tolerance	Zhou Bin
Electric Field Strength of Fundamental and Outside the Allocated bands	Ding Zai
Electric Field Radiated Emissions (< 30MHz)	Ding Zai
Electric Field Radiated Emissions (≥ 30 MHz)	Ding Zai
Conducted Emissions	Yang Mengke

ANNEX D: Accreditation Certificate

**United States Department of Commerce
National Institute of Standards and Technology**

Certificate of Accreditation to ISO/IEC 17025:2017

NVLAP LAB CODE: 600118-0

Telecommunication Technology Labs, CAICT
Beijing
China

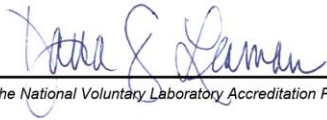
*is accredited by the National Voluntary Laboratory Accreditation Program for specific services,
listed on the Scope of Accreditation, for:*

Electromagnetic Compatibility & Telecommunications

*This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality
management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).*

2020-09-29 through 2021-09-30
Effective Dates




For the National Voluntary Laboratory Accreditation Program

*****END OF REPORT*****